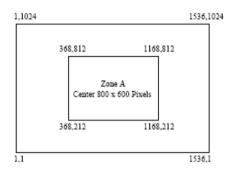


## DEFECT DEFINITIONS

## OPERATING CONDITIONS All tests performed at T=25oC

## SPECIFICATIONS

Classification	Column Defect		Cluster Defect		Point Defect	
	Total	Zone A	Total	Zone A	Total	Zone A
C1	≤5	≤2	0	0	0	0
C2	≤10	≤5	≤4	≤2	0	0



Point Defects

Dark: A pixel that deviates by more than 6% from neighboring pixels when illuminated to 70% of saturation

-- OR --

Bright: A pixel with a dark current greater than 5000e/pixel/sec at 25C.

Cluster Defect

A grouping of not more than 5 adjacent point defects

Column Defect

A grouping of more than 5 contiguous point defects along a single column

A column containing a pixel with dark current greater than 12,000e/pixel/sec [[bright column].

A column that does not meet the minimum vertical CCD charge capacity (low charge capacity

column)

A column which loses more than 250 e under 2Ke illumination (trap defect)

Neighboring Pixels

The surrounding 128 x 128 pixels or ± 64 column/rows

Defect Separation

Column and cluster defects are separated by no less than two [2] pixels in any direction

(excluding single pixel defects)